

## OptiMOS<sup>®</sup> -T Power-Transistor



### Product Summary

$V_{DS}$	100	V
$R_{DS(on),max}$ (SMD version)	15.4	m $\Omega$
$I_D$	50	A

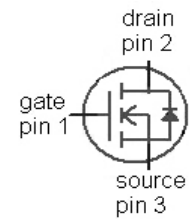
### Features

- N-channel - Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green product (RoHS compliant)
- 100% Avalanche tested

PG-TO263-3-2      PG-TO262-3-1      PG-TO220-3-1



Type	Package	Marking
IPB50N10S3L-16	PG-TO263-3-2	3N10L16
IPI50N10S3L-16	PG-TO262-3-1	3N10L16
IPP50N10S3L-16	PG-TO220-3-1	3N10L16



**Maximum ratings**, at  $T_j=25\text{ }^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	$I_D$	$T_C=25\text{ }^\circ\text{C}$ , $V_{GS}=10\text{ V}$	50	A
		$T_C=100\text{ }^\circ\text{C}$ , $V_{GS}=10\text{ V}^{1)}$	37	
Pulsed drain current <sup>1)</sup>	$I_{D,pulse}$	$T_C=25\text{ }^\circ\text{C}$	200	
Avalanche energy, single pulse <sup>1)</sup>	$E_{AS}$	$I_D=25\text{ A}$	330	mJ
Avalanche current, single pulse	$I_{AS}$		50	A
Gate source voltage <sup>2)</sup>	$V_{GS}$		$\pm 20$	V
Power dissipation	$P_{tot}$	$T_C=25\text{ }^\circ\text{C}$	100	W
Operating and storage temperature	$T_j, T_{stg}$		-55 ... +175	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1			55/175/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
<b>Thermal characteristics<sup>1)</sup></b>						
Thermal resistance, junction - case	$R_{thJC}$		-	-	1.5	K/W
Thermal resistance, junction - ambient, leaded	$R_{thJA}$		-	-	62	
SMD version, device on PCB	$R_{thJA}$	minimal footprint	-	-	62	
		6 cm <sup>2</sup> cooling area <sup>3)</sup>	-	-	40	

**Electrical characteristics, at  $T_j=25\text{ °C}$ , unless otherwise specified**

**Static characteristics**

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=1\text{ mA}$	100	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=60\mu\text{A}$	1.2	1.7	2.4	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=80\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ °C}$	-	0.01	1	$\mu\text{A}$
		$V_{DS}=80\text{ V}, V_{GS}=0\text{ V}, T_j=125\text{ °C}^{2)}$	-	1	100	
Gate-source leakage current	$I_{GSS}$	$V_{GS}=16\text{ V}, V_{DS}=0\text{ V}$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=4.5\text{ V}, I_D=50\text{ A}$	-	16.1	20.9	m $\Omega$
		$V_{GS}=4.5\text{ V}, I_D=50\text{ A},$ SMD version	-	15.8	20.6	
		$V_{GS}=10\text{ V}, I_D=50\text{ A}$	-	13.1	15.7	
		$V_{GS}=10\text{ V}, I_D=50\text{ A},$ SMD version	-	12.8	15.4	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

### Dynamic characteristics<sup>1)</sup>

Input capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=25V,$ $f=1MHz$	-	3215	4180	pF
Output capacitance	$C_{oss}$		-	730	949	
Reverse transfer capacitance	$C_{rss}$		-	63	95	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=20V, V_{GS}=10V,$ $I_D=50A, R_G=3.5\Omega$	-	10	-	ns
Rise time	$t_r$		-	5	-	
Turn-off delay time	$t_{d(off)}$		-	28	-	
Fall time	$t_f$		-	5	-	

### Gate Charge Characteristics<sup>1)</sup>

Gate to source charge	$Q_{gs}$	$V_{DD}=80V, I_D=70A,$ $V_{GS}=0\text{ to }10V$	-	9	12	nC
Gate to drain charge	$Q_{gd}$		-	8	12	
Gate charge total	$Q_g$		-	49	64	
Gate plateau voltage	$V_{plateau}$		-	3.7	-	V

### Reverse Diode

Diode continuous forward current <sup>1)</sup>	$I_S$	$T_C=25^\circ C$	-	-	50	A
Diode pulse current <sup>1)</sup>	$I_{S,pulse}$		-	-	200	
Diode forward voltage	$V_{SD}$	$V_{GS}=0V, I_F=50A,$ $T_j=25^\circ C$	0.6	1	1.2	V
Reverse recovery time <sup>1)</sup>	$t_{rr}$	$V_R=50V, I_F=I_S,$ $di_F/dt=100A/\mu s$	-	80	-	ns
Reverse recovery charge <sup>1)</sup>	$Q_{rr}$		-	185	-	nC

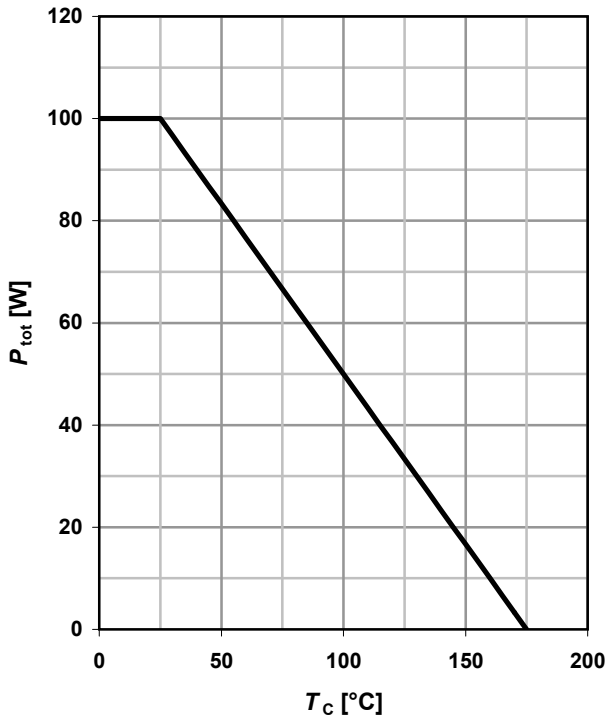
<sup>1)</sup> Defined by design. Not subject to production test.

<sup>2)</sup> Qualified with  $V_{GS} = +20/-5V$ .

<sup>3)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

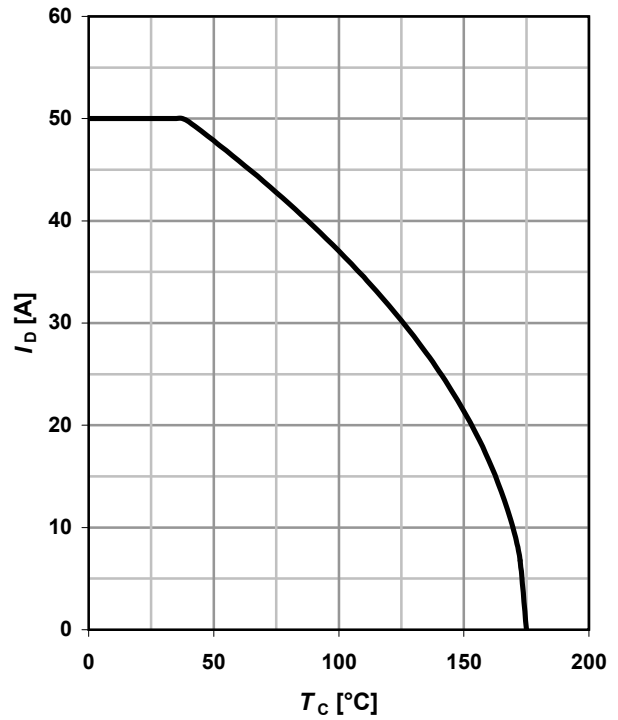
**1 Power dissipation**

$P_{tot} = f(T_C); V_{GS} \geq 6 V$



**2 Drain current**

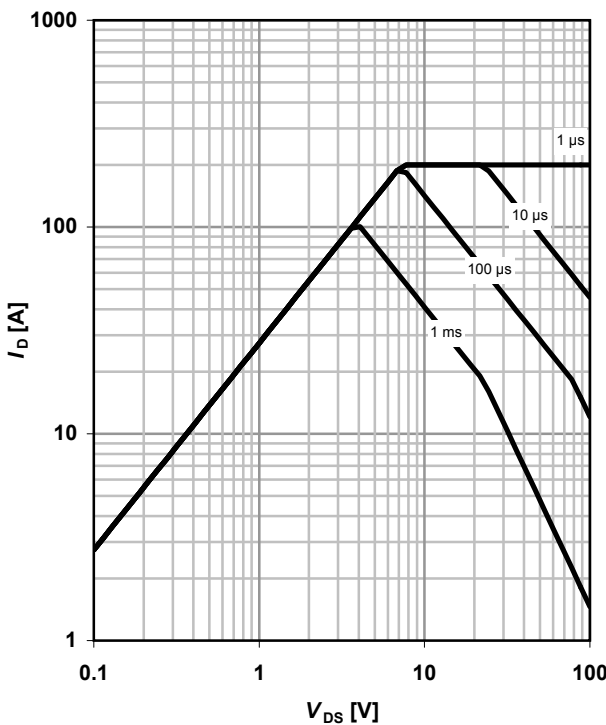
$I_D = f(T_C); V_{GS} \geq 6 V; SMD$



**3 Safe operating area**

$I_D = f(V_{DS}); T_C = 25^\circ C; D = 0; SMD$

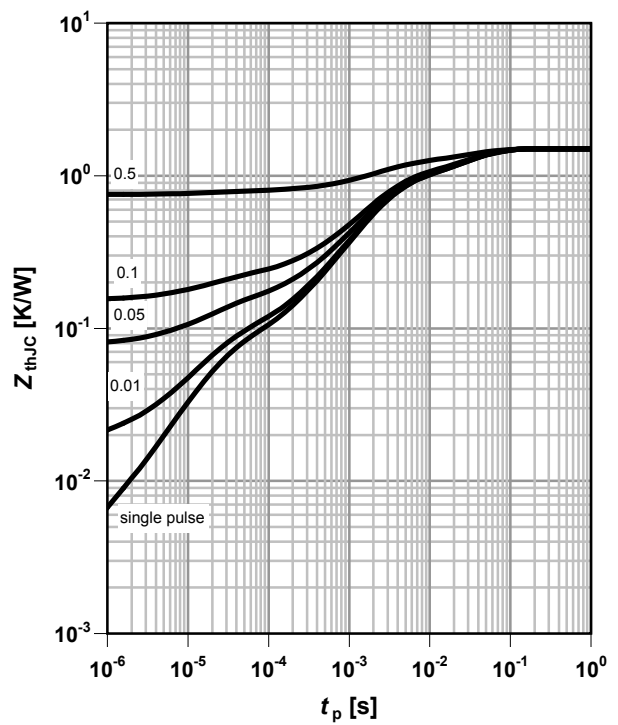
parameter:  $t_p$



**4 Max. transient thermal impedance**

$Z_{thJC} = f(t_p)$

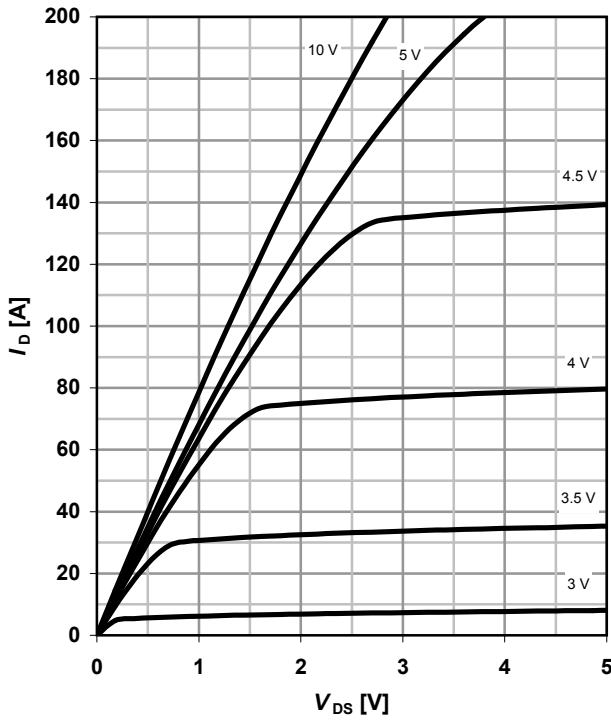
parameter:  $D = t_p/T$



**5 Typ. output characteristics**

$I_D = f(V_{DS}); T_j = 25\text{ }^\circ\text{C}; \text{SMD}$

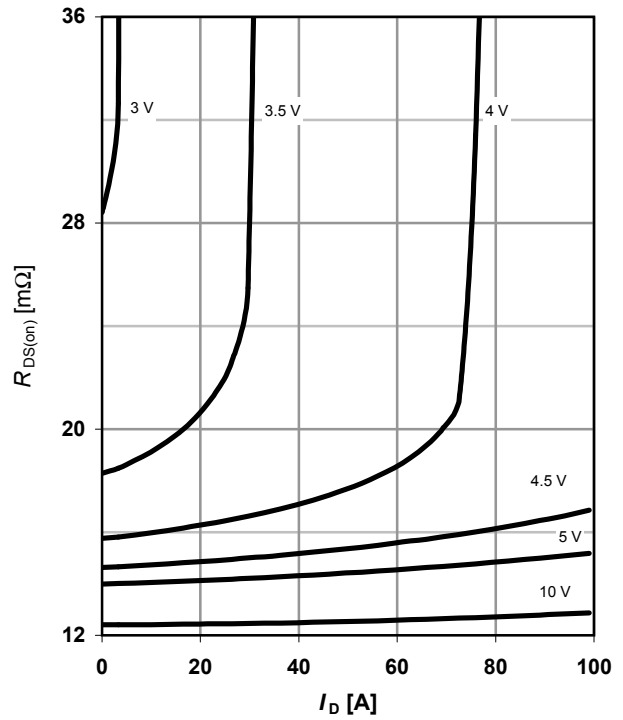
parameter:  $V_{GS}$



**6 Typ. drain-source on-state resistance**

$R_{DS(on)} = f(I_D); T_j = 25\text{ }^\circ\text{C}; \text{SMD}$

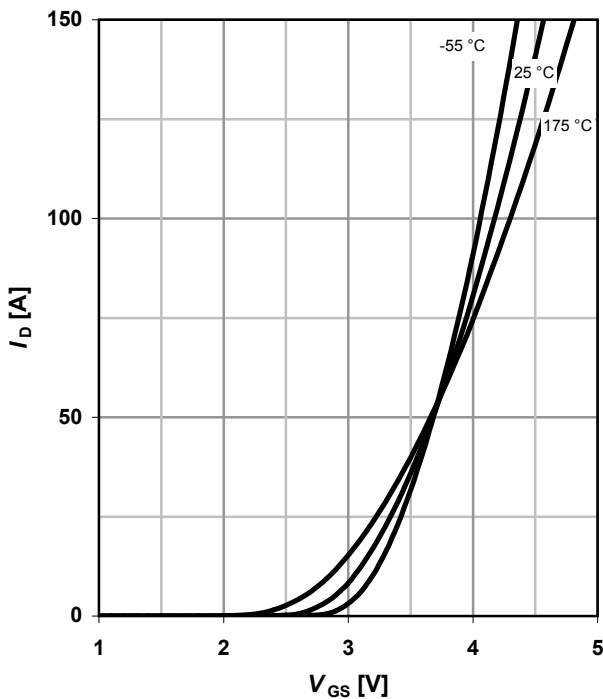
parameter:  $V_{GS}$



**7 Typ. transfer characteristics**

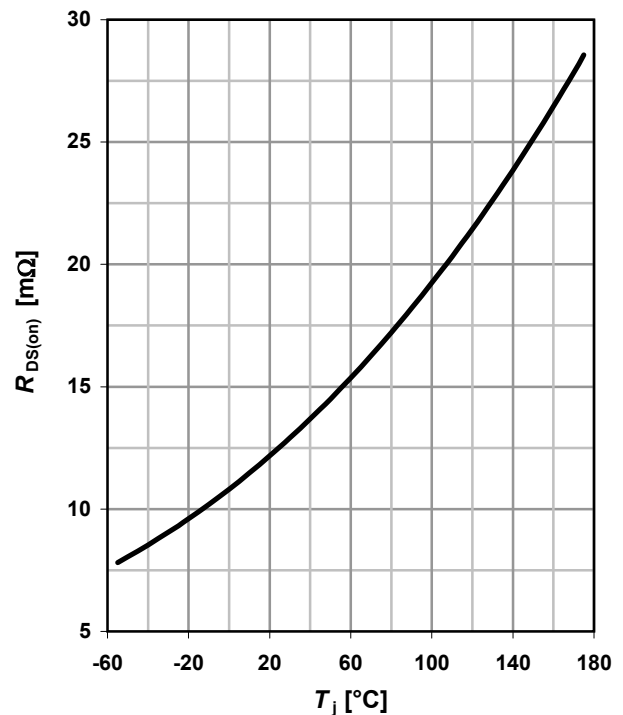
$I_D = f(V_{GS}); V_{DS} = 6\text{V}$

parameter:  $T_j$



**8 Typ. drain-source on-state resistance**

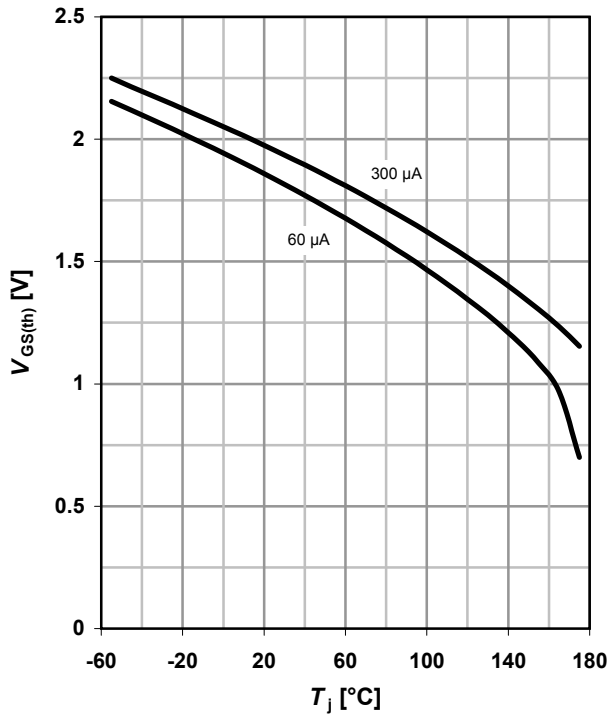
$R_{DS(on)} = f(T_j); I_D = 50\text{ A}; V_{GS} = 10\text{ V}; \text{SMD}$



**9 Typ. gate threshold voltage**

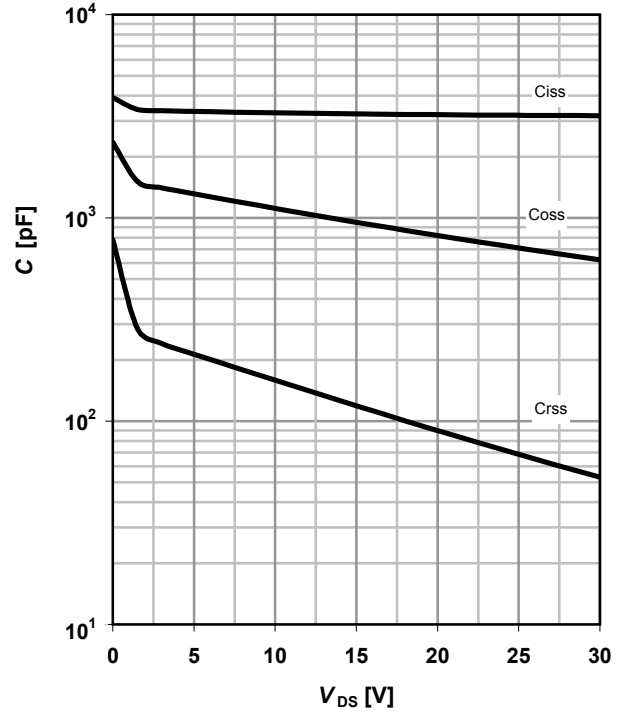
$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter:  $I_D$



**10 Typ. capacitances**

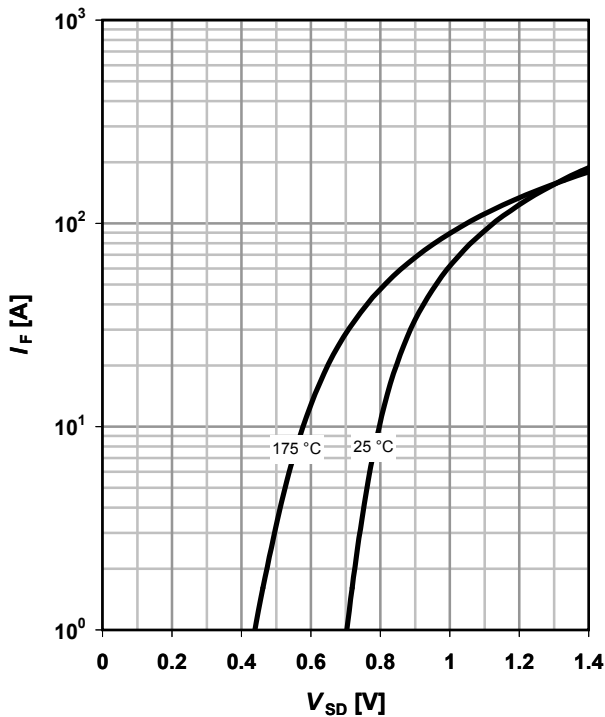
$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$



**11 Typical forward diode characteristics**

$I_F = f(V_{SD})$

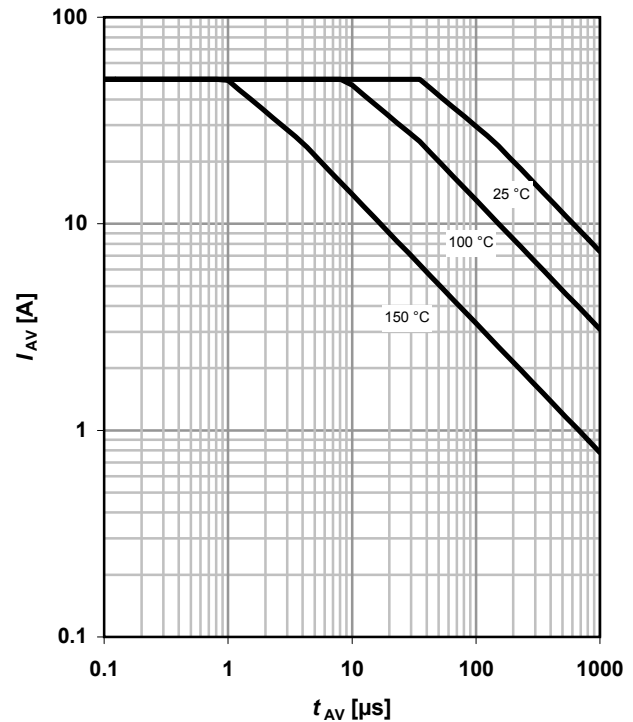
parameter:  $T_j$



**12 Typ. avalanche characteristics**

$I_{AS} = f(t_{AV})$

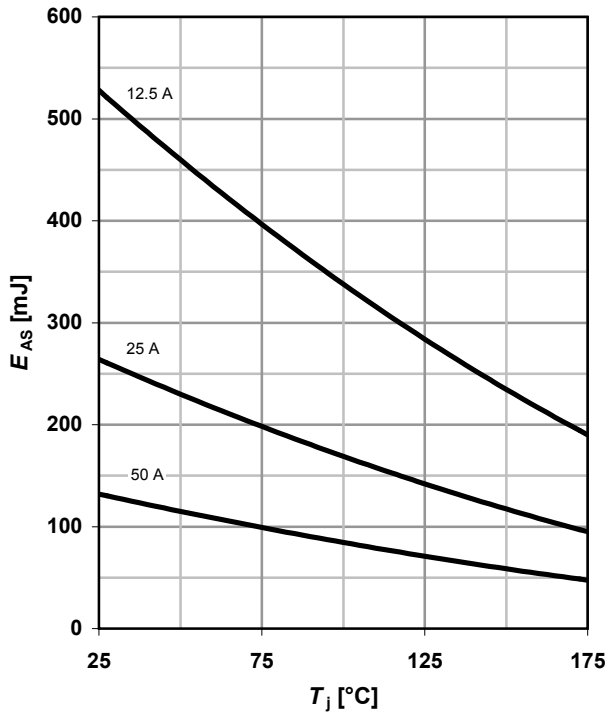
parameter:  $T_{j(start)}$



**13 Typical avalanche energy**

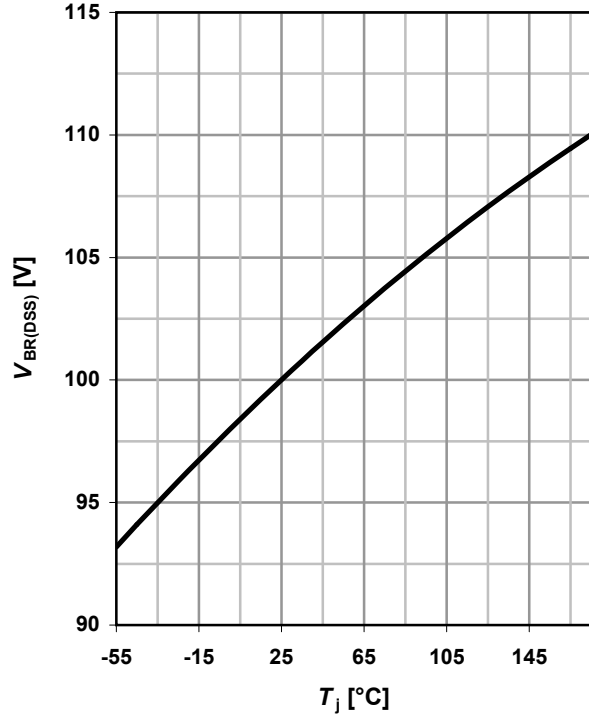
$$E_{AS} = f(T_j)$$

parameter:  $I_D$



**14 Typ. drain-source breakdown voltage**

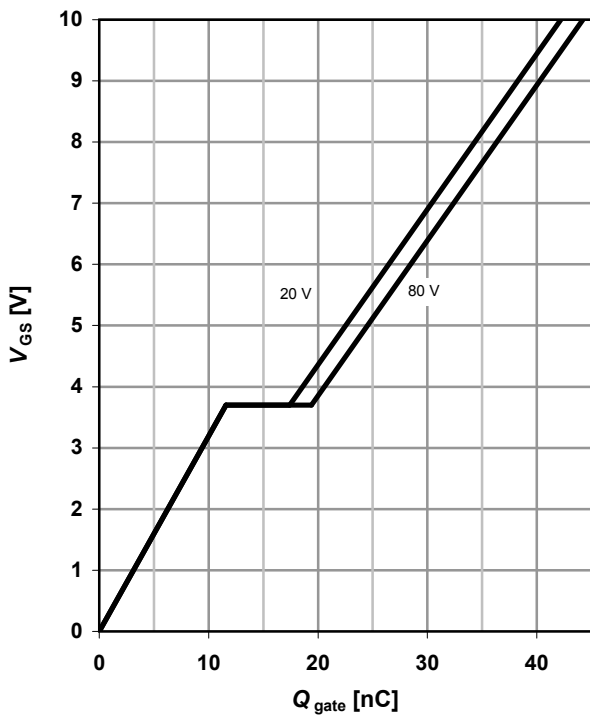
$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$



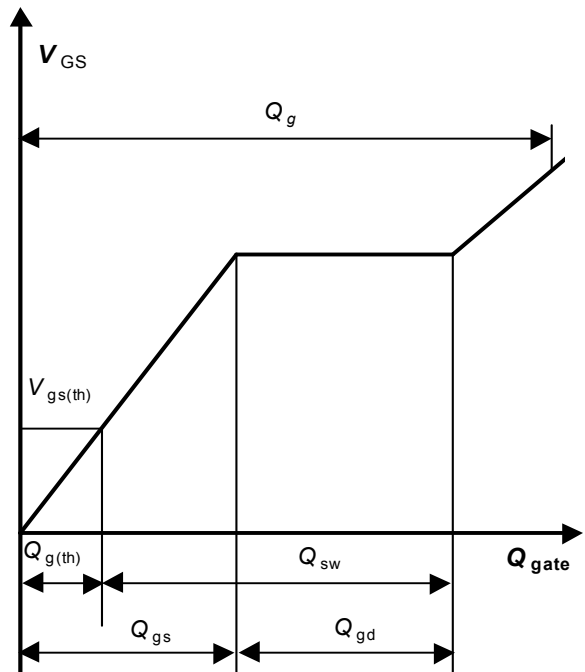
**15 Typ. gate charge**

$$V_{GS} = f(Q_{gate}); I_D = 50 \text{ A pulsed}$$

parameter:  $V_{DD}$



**16 Gate charge waveforms**



**Published by**  
**Infineon Technologies AG**  
**81726 Munich, Germany**

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Revision History

Version	Date	Changes
1.1	08.04.2008	Page 1: VGS changed from $\pm 16V$ to $\pm 20V$
1.1	08.04.2008	Page 3: Footnote 2) added
1.1	09.04.2008	Page 1: EAS changed from 264mJ to 330mJ

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